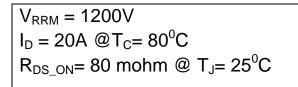


1200V/80 m Ω SiC MOSFET in SOT-227 Package





Features

- High speed switching SiC MOSFET
- Freewheeling diode with zero reverse recovery SiC SBDs
- Low R_{DS ON}
- Simple to drive
- Low stray inductance
- High junction temperature operation
- Easy to parallel and mounting



- Photo Voltaic Inverter
- Motor Driver
- Multi-level Converter
- High voltage AC/DC Converter



- Outstanding power conversion efficiency at high switching frequency operation
- Low switching losses and Low EMI noises
- Very rugged and easy mount
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive Tc of VF
- Reduced cooling requirement
- RoHS Compliant



Absolute Maximum Ratings (T_i=25°C unless otherwise specified)

Parameters	Symbol	Conditions	Specifications	Units
SIC MOSFET	<u> </u>	•	-	<u>'</u>
Maximum Drain-Source Voltage	V _{DSS}	$T_j = 25 ^{\circ}\text{C}^{\sim}150 ^{\circ}\text{C}$	1200	V
Continuous Drain Current	I _D	$T_j = 25$ °C, $V_{GS} = 20V$	40	А
		$T_j = 150$ °C, $V_{GS} = 20V$	20	А
Pulsed Drain Current	I _{DS}	Limited by Tj_max	60	А
Gate-Source Voltage	V _{GS}		-10/+25	V
Maximum Power Dissipation	P _D	$T_C = 25$ $^{\circ}C$	TBD	W
		$T_{\rm C} = 100^{0}{\rm C}$	TBD	W
Operating Junction Temperature	Tj		-40 ~ 150	°C
Storage Temperature	T _{STG}		-40 ~ 125	°C
SiC SBDs	1	1	1	4
Maximum Reverse Voltage	V_{RRM}		1200	V
Average Forward Current	I _{DAV}	$T_j = 25$ 0 C	20	Α
		$T_j = 150^{\circ}C$	7	А
Non-repetitive Forward Surge Current	I _{FSM}	T _C =25 °C, t _p =8.3 ms	120	А
Non-repetitive Forward Surge Current	I _{F,MAX}	T _C =25 °C, t _p =10 μs	700	А

Electrical Characteristics (T_j=25°C unless otherwise specified)

Parameters	Symbol	Conditions	Min	Тур	Max	Units
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =100μA	1200			V
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2.5 \text{ mA}, T_j = 25 ^{\circ}\text{C}$	1.7	2.2		V
		$V_{GS} = V_{DS}$, $I_D = 2.5 \text{mA}$, $T_j = 150^{\circ} \text{C}$		1.6		V
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} =1200V, V_{GS} =0V, T_j = 25 0 C		1	100	μΑ
		V_{DS} =1200V, V_{GS} =0V, T_j = 150 0 C		TBD		μΑ
Gate Source Leakage Current	I _{GSS}	V _{GS} =20V, V _{DS} =0V			250	nA
Internal Gate Resistance	R _G	f = 1MHz, V _{AC} = 25mV,		1.5		Ω
		ESR of C _{iss}				
Drain-Source On-state Resistance	R _{DS(ON)}	$V_{GS} = 20V, I_D = 20A, T_j = 25$ °C		80		mΩ
		$V_{GS} = 20V, I_D = 20A, T_j = 150 {}^{0}C$		150		mΩ
Input Capacitance	C _{ISS}	V _{GS} = 0V, V _{DS} = 800V, freq =		950		pF
Output Capacitance	C _{oss}	1MHz, V _{AC} = 25mV, measured		80		pF
Reverse transfer Capacitance	C _{rSS}	at one MOSFET.		6.5		pF
Turn-on Delay Time	t _{d(on)i}	$V_{DS} = 800V, V_{GS} = -5/20V$		15		ns
Rise Time	t _{ri}	$I_D = 20A$, $R_{G(ext)} = 2.5\Omega$,		35		ns
Turn-off Delay Time	t _{d(off)i}	- L = 856μH		32		ns



Fall Time	t _{fi}			26		ns
Turn-on Switching Loss	E _{ON}			0.4		mJ
Turn-off Switching Loss	E _{OFF}			0.25		mJ
Body Diode Forward Voltage	V _{SD}	$I_F = 10A, T_j = 25$ $^{\circ}C$		3.3		V
		$I_F = 10A, T_j = 150$ °C		TBD		٧
Total Gate Charge	Qg	V _{DS} =800 V, V _{GS} = -5/20V		49.2		nC
Gate-Source Charge	Q _{GS}	$I_D = 20A$		10.8		nC
Gate-Drain Charge	Q_{GD}			18		nC
SiC SBDs				•		
Maximum peak repetitive reverse voltage	V_{RRM}		1200			V
Maximum Reverse Leakage Current	I _{RM}	$V_R = 1200V, T_j = 25^{\circ}C$		2	20	μΑ
		$V_R = 1200V, T_j = 150$ °C		23	200	μΑ
Diode Forward Voltage	V _F	$I_F = 10A, T_j = 25$ °C		1.5	1.7	V
		$I_F = 10A, T_j = 150$ °C		2	2.6	V
Total Capacitive Charge	Q _C	V _R = 800 V		56		nC
Total Capacitance	С	V _R = 1V, f = 1 MHz		608		pF
		V _R = 400V, f = 1 MHz		53		pF
		V _R = 800V, f = 1 MHz		39		pF

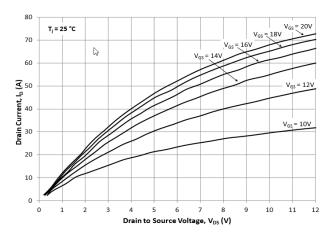
Thermal and Package Characteristics ($T_j = 25^{\circ}C$ unless otherwise specified)

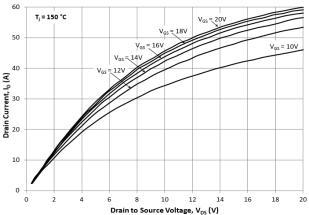
Parameters Symb		Conditions	Min	Тур	Max	Units
Junction to Case Thermal Resistance	R _{THJC}	Per MOSFET			0.6	°C /W
		Per SBD			2.2	°C /W
Mounting Torque	M_d				1.5	N-m
Terminal Connection Torque	M _{dt}		1.3		1.5	N-m
Package Weight	W _t			32		g
Isolation Voltage	V _{ISOL}	I _{ISOL} < 1mA, 50/60Hz, t=1 min	2500			V

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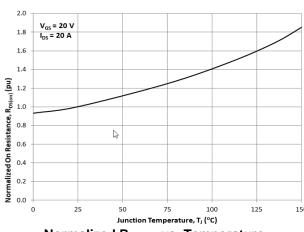
MOSFET Typical Characteristics

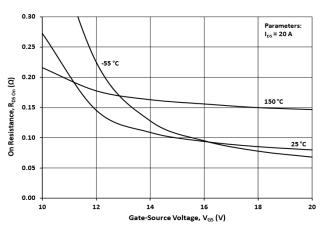




Typical Forward Characteristics T_j=25 °C

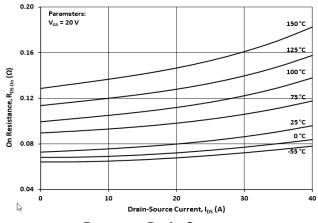
Typical Forward Characteristics T_j=150 °C

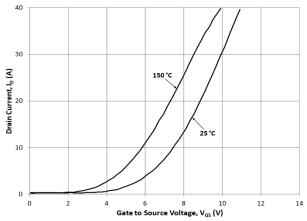




Normalized R_{DS_ON} vs. Temperature

R_{DS_ON} vs. Gate Voltage

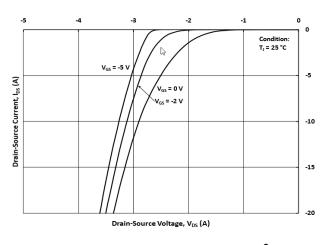


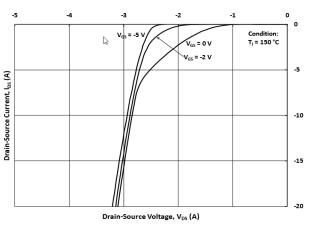


 $R_{\text{DS_ON}}$ vs. Drain Current

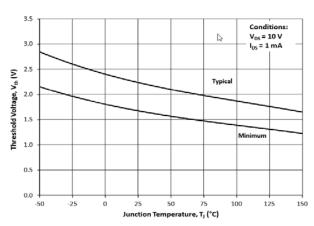
Transfer Characteristics



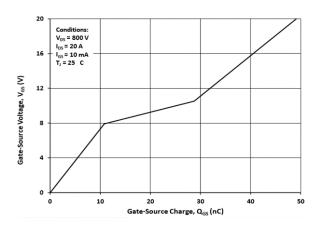




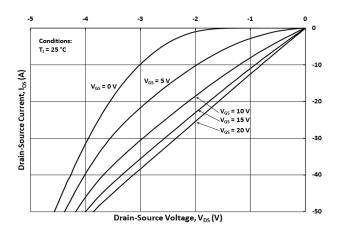
Body Diode Characteristics T_j=25 °C



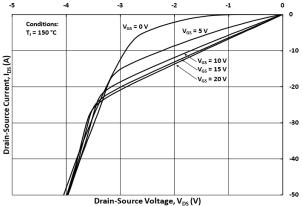
Body Diode Characteristics T_i=150 °C



Threshold Voltage vs. Temperature



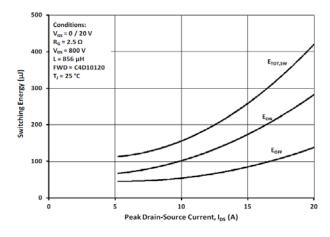
Gate Charge Characteristics

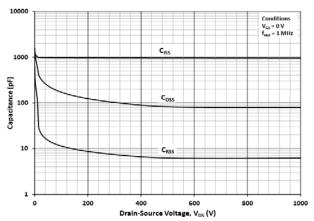


 3^{rd} Quadrant Characteristics T_i =25 °C

3rd Quadrant Characteristics T_i=150 °C

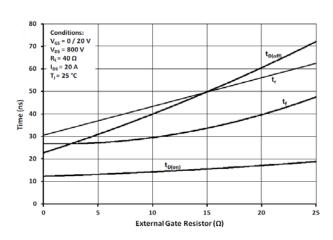


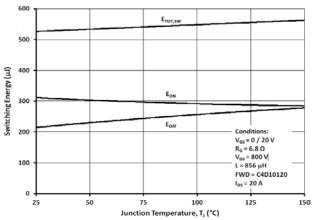




Switching Loss vs. Drain Current (V_{DD}=800V)

Capacitances vs. Drain-Source Voltage (0~1k V)

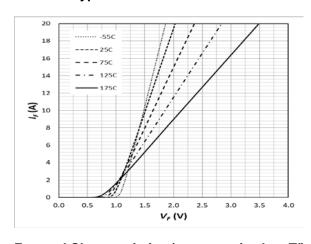


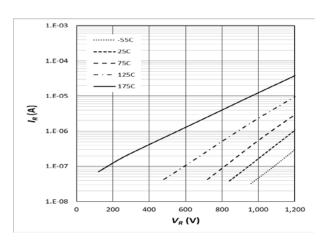


Resistive Switching Time vs. R_{G(ext)}

Clamped Inductive Switching Energy vs. Temperature

SiC SBD Typical Characteristics



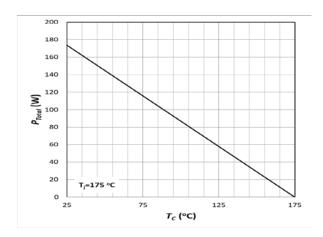


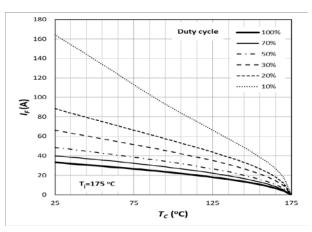
Forward Characteristics (parameterized on Tj)

Reverse Characteristics (parameterized on Tj)

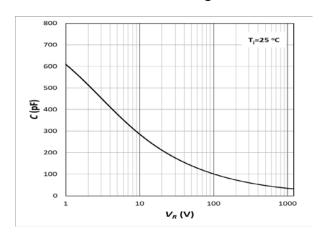
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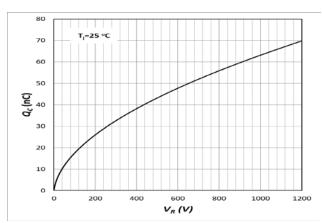




Power Derating



Current Derating



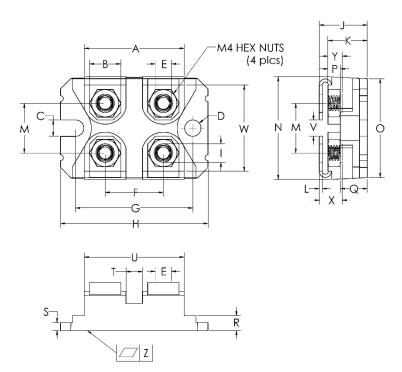
Capacitance

Recovery Charge

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SOT-227 Package Outline and Dimension



0	Millim	neters	Inc	hes
Sym	Min M		Min	Max
Α	31.67	31.90	1.247	1.256
В	7.95	8.18	0.313	0.322
С	4.14	4.24	0.163	0.167
D	4.14	4.24	0.163	0.167
Е	4.14	4.24	0.163	0.167
F	14.94	15.09	0.588	0.594
G	30.15	30.25	1.187	1.191
Н	38.00	38.10	1.496	1.500
ı	4.75	4.83	0.187	0.190
J	11.68	12.19	0.460	0.480
K	9.45	9.60	0.372	0.378
L	0.76	0.84	0.030	0.033
М	12.62	12.88	0.497	0.507
N	25.15	25.30	0.990	0.996
0	24.79	25.04	0.976	0.986
Р	3.02	3.15	0.119	0.124
Q	6.71	6.96	0.264	0.274
R	4.17	4.42	0.164	0.174
S	2.08	2.13	0.082	0.084
Т	3.28	3.63	0.129	0.143
U	26.75	26.90	1.053	1.059
V	3.86	4.24	0.152	0.167
W	20.55	26.90	0.809	0.814
Χ	5.45	5.85	0.215	0.230
Υ	3.15	3.66	0.124	0.144
Z	0.00	0.13	0.000	0.005



Revision History

Date	Revision	Notes
10/3/2016	0.1	Initial release
01/03/2020	0.2	Applied company name change
05/27/2020	0.3	Updated mechanical drawing
07/24/2020	0.4	Updated SBD specification

Notes

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of www.SemiQ.com.

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25.163.2453.0 25.3	163.4253.0	25.190.2053.0	25.194.3453.0	25.320.4853.1	25.320.5253.1	25.326.3253.1	25.326.3553.1	25.330.1653.1
25.330.4753.1 25.3	330.5253.1	25.334.3253.1	25.334.3353.1	25.350.2053.0	25.352.4753.1	25.522.3253.0	<u>T483C</u> <u>T484C</u>	<u>T485F</u> <u>T485H</u>
T512F-YEB T513	F T514F T	554 <u>T612FSE</u>	25.161.3453.0	25.179.2253.0	25.194.3253.0	25.325.1253.1	25.326.4253.1	25.330.0953.1
25.332.4353.1 25.3	350.1653.0	25.350.2453.0	25.352.1453.0	25.352.1653.0	25.352.2453.0	25.352.5453.1	25.522.3353.0	25.602.4053.0
25.640.5053.0								